

Signatures of a nanoflare heated solar corona ①

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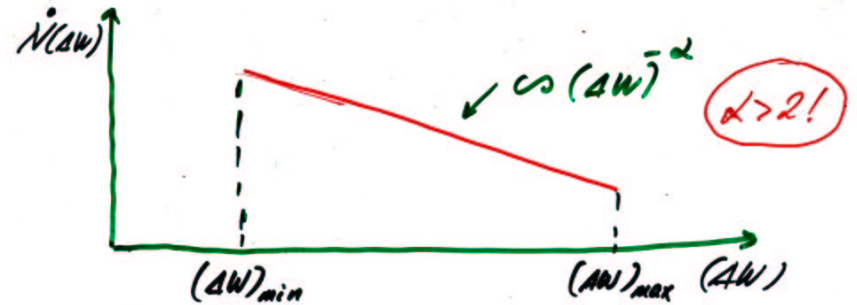
(in collaboration with REXHA GAIN, UMIST) and YUKIO KATUKAWA (Univ. of Tokyo)

\* Assume that high coronal temperature is maintained by numerous small flare-like events (nanoflares)

xx) How this scenario can be tested without resolving individual nanoflares

Statistical properties of hot coronal loops

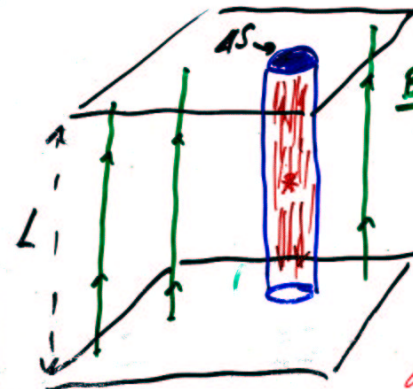
Broad energy spectrum of heating events (nanoflares) ②



$$\int_{(dW)_{min}}^{\infty} N(dW) = \frac{q (d-2)}{(d-1) (dW)_{min}}$$

$q$  - heating rate per unit area ( $q \sim 10^2 \text{ erg/cm}^2 \cdot \text{s}$ )

Each nanoflare  $\rightarrow$  single hot filament



$$2n_0 k T_0 = B^2 / 4\pi$$

$$\Delta W = 5n_0 k T_0 \cdot L \cdot h$$

$$\Delta S = \frac{16\pi}{5} \frac{\Delta W}{8^2 L}$$

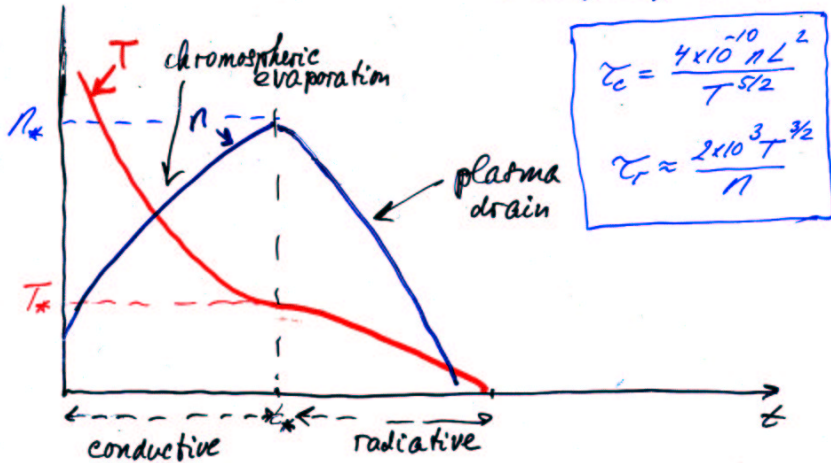
Lower limit for  $\Delta S$  under strongly localized energy dissipation  
 $(\Delta S)_{min} \sim 10^{14} \text{ cm}^2$

### Cooling of a hot filament

③

two-stage process: conductive phase + radiative phase

(Cargill, 1999)

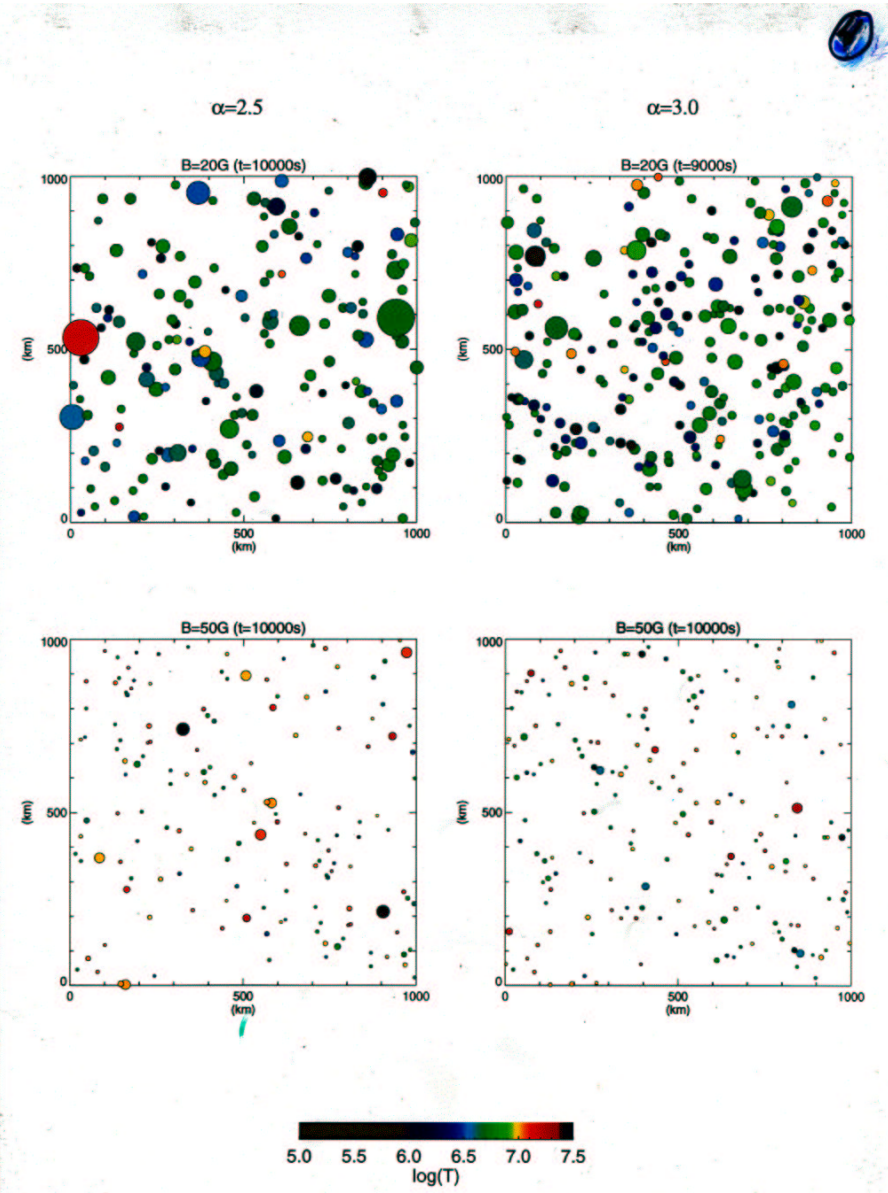


$$(\Delta t)_h = (\Delta t)_c + (\Delta t)_r = 2\tau_c \approx 10^{-4} L^{5/2} B^{-3/2}$$

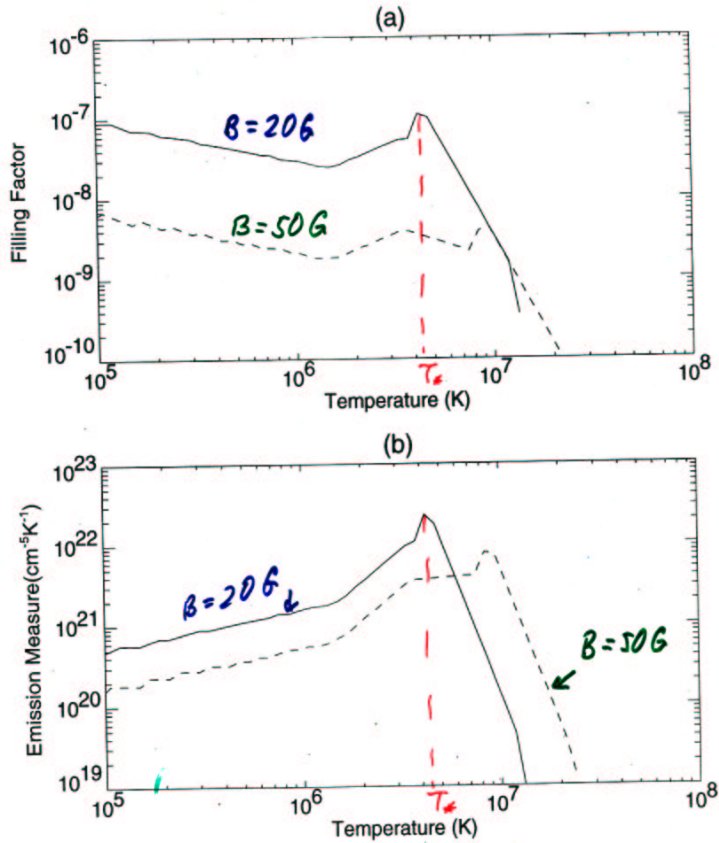
Example:  $B = 30 \text{ G}; L = 10^3 \text{ cm}$

$$(\Delta t)_h \approx 10^3 \text{ s}$$

$t \gg (\Delta t)_h \rightarrow$  statistical steady state  $\rightarrow$  broad distribution of filaments with temperature and density



⑤



⑥

Scaling laws for active region loops (Vekstein & Katsurawa, ApJ, 2000)

\*1) Temperature of the loop detected by a broad-range K-ray telescope

$$T \approx T_* = 4 \times 10^2 B^{2/3} L^{1/3}$$

$L \approx 10^9 \text{ cm}; B = 30G$

RTV scaling with the pressure inside the filament equal to the external magnetic pressure

$T_* \approx 4 \times 10^6 \text{ K}$   
 $n_* \approx 3.2 \times 10^{10} \text{ cm}^{-3}$

\*\*1) Filling factor for the loop

number of hot filaments in the loop

$$N = N_* \times S \times (\Delta t)_h \approx \frac{q}{(AM)_{\min}} \times S \times (\Delta t)_h \approx$$

Example:  $L=10^9; B=30; S=10^{18} \text{ cm}^2; q=10^7 \rightarrow$   
 $N \approx 2 \times 10^4$

filling factor

$$f \approx N_* \frac{AS}{S} \approx 2 \times 10^3 q / B^{2/3} L^{1/6}$$

Normally, filling factor is small ( $f \approx 10^{-1} \div 10^{-3}$ )

xxx) Total thermal energy

$$W_T = 3n_e T_e f \cdot L \cdot S \approx 10^4 L^{5/6} d^2 B^{-1/3}$$

xxx) Total emission measure

$$(EM)_t \approx n_e^2 f V \approx 2 \times 10^{20} B^{1/3} d^2 L^{1/6}$$

How these compare with observations?

Active region loops observed with Yohkoh SXT  
(Cargill & Klimchuk, 1997)

How the above  $W_T$  and  $(EM)_t$  relate with observational scalings?

(Golub et al, 1980):  $W_T \propto \varphi^{3/2} \propto B^{3/2} d^3$

(Shibata et al, 2001):  $W_T \propto \varphi^{4/3} \propto B^{4/3} d^{2/3}$

(Fisher et al, 1998):  $(EM)_t \propto \varphi^{1.2} \propto B^{1.2} d^{2.4}$

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TABLE 1  
ACTIVE REGION LOOPS OBSERVED BY YOHKOH SXT

Parameter (1)	Loop 1 (2)	Loop 2 (3)	Loop 3 (4)	Loop 4 (5)	Loop 5 (6)
$L(10^6 \text{ cm})^*$	3.82	4.53	3.08	3.20	8.16
$d(10^6 \text{ cm})^*$	1.48	1.15	1.55	2.12	1.45
$T(10^6 \text{ K})^*$	6.39	4.47	7.25	1.88	2.05
$(EM)_t(10^{26} \text{ cm}^{-3})^*$	21	7.7	0.25	7.5	240
$B(G)^*$	33	18	44	5.8	4.1
$d(10^6 \text{ ergs cm}^{-2} \text{ s}^{-1})^*$	3.8	2.7	0.04	1.2	80
$f^*$	$5.6 \times 10^{-2}$	$1.6 \times 10^{-1}$	$3.1 \times 10^{-4}$	$\approx 1$	$> 1$

\* Observed parameters.  
\* Those derived from scaling laws (eqs. [14]-[17]).

All the above characteristics depend only on  $q$  - the average energy input

How to probe  $(AW)_{min}$  and  $\alpha$ ??

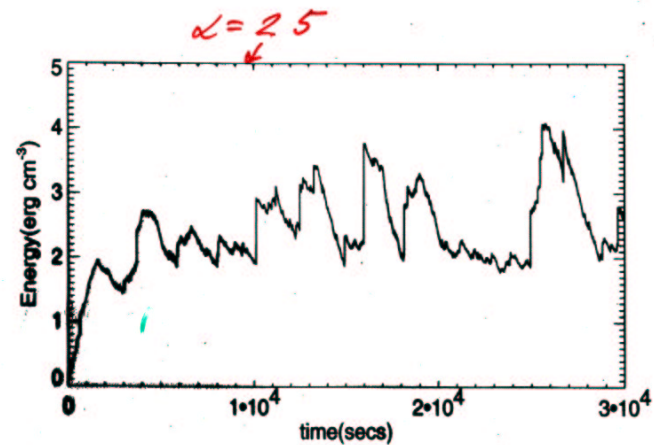
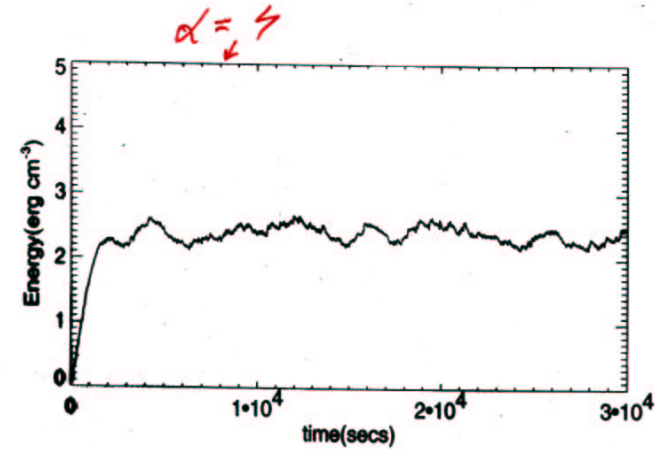
Variability (transient brightenings) in the coronal X-ray emission

Present observational data are quite controversial regarding the spectral index  $\alpha$  of transient brightenings (observation of big events with extrapolation to small events)

Benz & Krucker, 1998, 2001 }  $\alpha > 2$   
 Parnell & Jupp, 2000 }

Aschwanden et al, 2000 }  $\alpha < 2$   
 Berghmans et al, 1999 }

Results are very sensitive to the imported data analysis procedure as well as to assumptions on the structure of the emitting plasma (i.e. filling factor)



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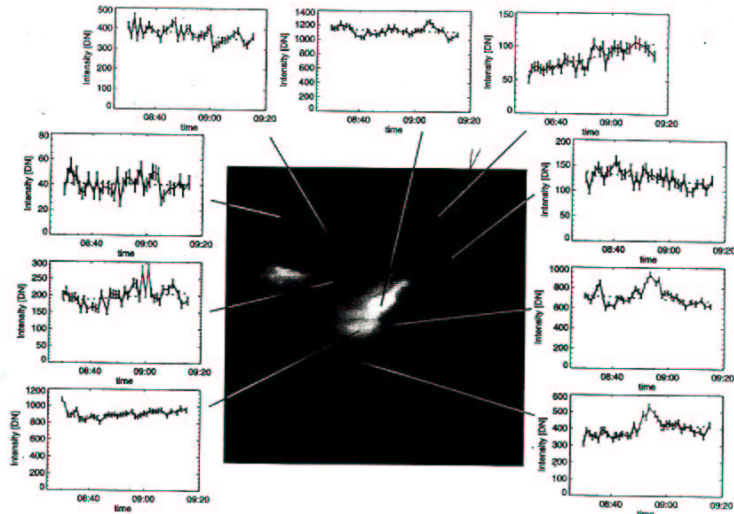


FIG. 1.—Sample light curves of the X-ray intensity of 9 pixels. The horizontal axis is time, and the total duration is one observing sequence (~40 minute). The vertical axis is the X-ray intensity and the units are DN (the data number of SXT). The error bars indicate  $\sigma_n$ , the standard deviation due to the photon noise. The thin solid lines represent the removed transient brightenings, and the data points marked with thick solid lines are used. The dashed lines in the panels are the mean intensity levels of the corona  $I_0$ , derived from a linear fit (see text). [See the electronic edition of the Journal for a color version of this figure.]

X-ray intensity of individual pixels  
 (SXT, Katukawa & Tameta, Ap. J., 2001)

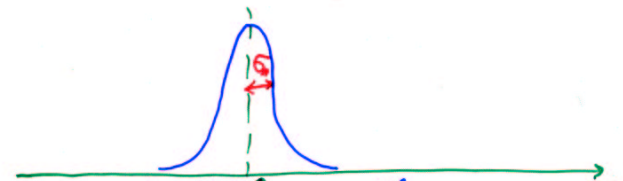
Histogram of the X-ray intensity  
What it may look like?

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\* all nanoflares have the same energy ( $\Delta W$ )

$$I_0 = \langle I \rangle = C S \tau_c \eta$$

- $\tau_c$  - exposure time
- $S$  - area of a pixel
- $\eta$  - heat flux to the corona ( $\text{erg}/\text{cm}^2 \cdot \text{s}$ )
- $C$  - conversion coefficient of the instrument



Gaussian distribution with  $\Delta I$

$$\sigma_n = I_0 / \sqrt{N}$$

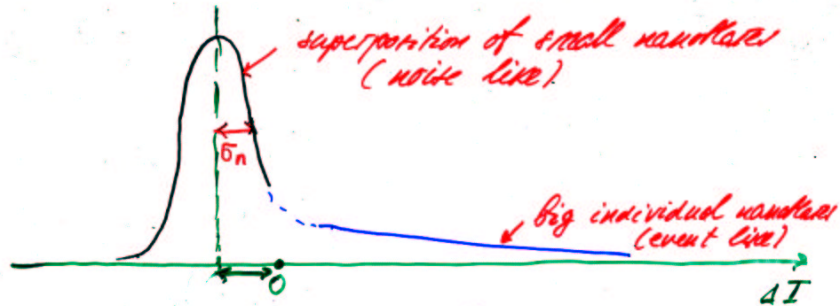
$\langle N \rangle$  average number of the emitting hot filaments

$$\langle N \rangle = \frac{\eta}{\Delta W} \cdot S (\Delta t)_h \rightarrow \text{life-time of a hot filament}$$

$$\sigma_n = C^{1/2} I_0^{1/2} (\Delta W)^{1/2} [\tau_c / (\Delta t)_h]^{1/2}$$

\*\*x) Broad energy spectrum of nanoflares

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How to derive  $\sigma_n$ ?

$\langle \Delta N(E) \rangle = N(E) dE \cdot S(\Delta t)_h$  - average number of hot filaments within the energy interval  $(E, E+dE)$

$\downarrow$

$\delta(\Delta N(E)) = \sqrt{\langle \Delta N(E) \rangle}$

$\Delta \sigma_n^2(E) = \left[ c \tau_c \frac{E \cdot \delta(\Delta N(E))}{(\Delta t)_h} \right]^2 = \frac{c^2 \tau_c^2 E^2 N(E) dE S}{(\Delta t)_h}$

$\sigma_n = \sqrt{S \Delta \sigma_n^2(E)} = \frac{c \tau_c S}{(\Delta t)_h^{1/2}} \left[ \int_{(AW)_{min}}^{(AW)_{max}} E^2 N(E) dE \right]^{1/2}$

Power-law spectrum:  $N(E) \propto E^{-\alpha}$

i)  $\alpha > 3$ !!  $\sigma_n = c^{1/2} I_0^{1/2} (AW)_{eff}^{1/2} \left[ \tau_c / (\Delta t)_h \right]^{1/2}$

$(AW)_{eff} = \frac{(\alpha-2)}{(\alpha-3)} (AW)_{min}$

ii)  $\alpha < 3$  - big events dominate in fluctuations  
 $\downarrow$   
 no Gaussian noise-like part

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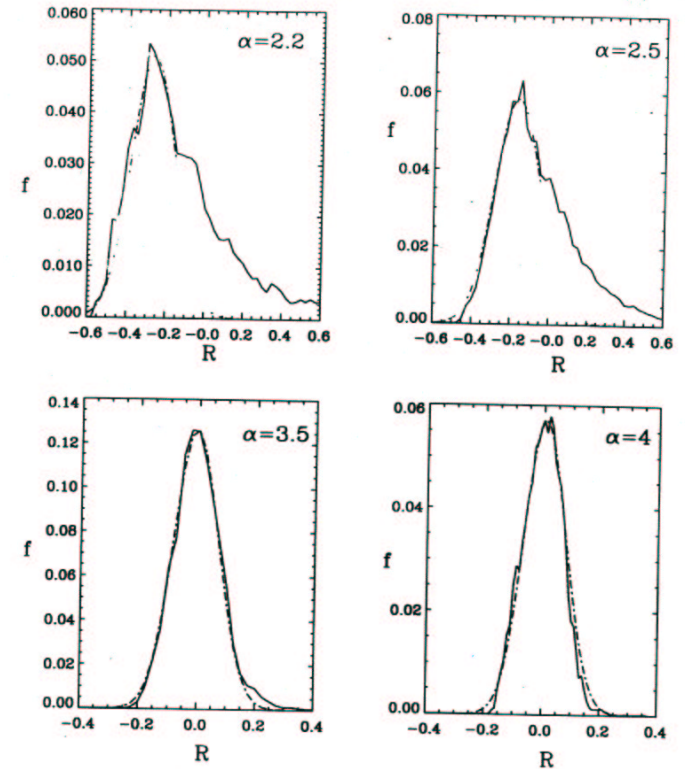


Figure 2. The fraction of events  $f$  versus the ratio of deviation  $\Delta I$  of the mean intensity  $I_0$  to  $I_0$  ( $R = \frac{\Delta I}{I_0}$ ) (see the text) for four different values of  $\alpha$ . The dot-dashed lines are the Gaussian best-fit to the core parts.

Numerical simulation of the X-ray intensity histogram

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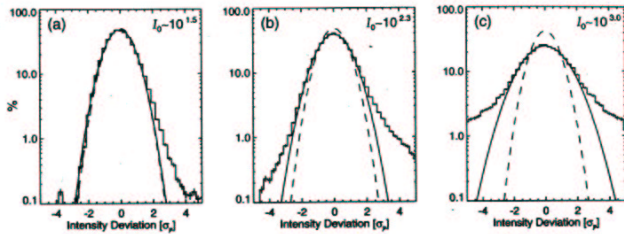


FIG. 2.—Histogram of the X-ray intensity fluctuation around the mean intensity  $I_0$  for three intensity levels: (a)  $I_0 \approx 10^{1.5}$ , (b)  $I_0 \approx 10^{2.5}$ , and (c)  $I_0 \approx 10^{3.5}$ . The unit of the horizontal axis is  $\sigma$ , the standard deviation due to the photon noise. The vertical axis is the number of data points expressed in percentage. The solid curves are the Gaussian best fitted to the core parts. The photon noise distributions are shown by dashed curves (see text).

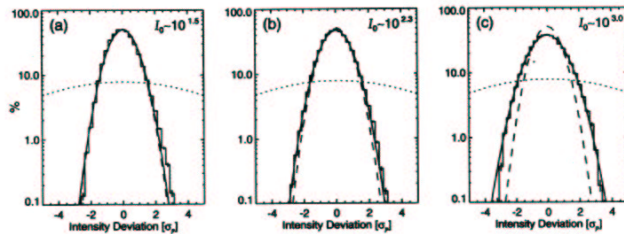


FIG. 3.—Histogram of the X-ray intensity fluctuation around the mean intensity  $I_0$  after removing the wing component (see text). The solid curves are Gaussian best fitted to the histograms. The photon noise distributions (dashed curves) and the distribution functions for  $\sigma_p/\sigma_n = 5$  (dotted curves; see text) are shown for comparison.

Histograms of the X-ray intensity for different SXT pixels (Kobunawa & Tsuneta, 2001)

Estimate of the nanoflare energy from the K T data.

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$\sigma_p$  (photon noise)  $\approx (1.5 \pm 0.3) I_0^{1/2}$   
 $\sigma_n > \sigma_p$  for  $I_0 \geq 5 \times 10^2 \Rightarrow \sigma_n \approx (2.08 \pm 0.03) I_0$

$I_0 \approx 10^3 \rightarrow \sigma_n \approx 10^2$

$(\Delta W)_{eff} = \frac{\sigma_n^2}{C I_0} \frac{(\Delta t)_h}{\tau_c}$

$\tau_c = 0.7s$ ;  $C = 10^{-20}$ ;  
 $(\Delta t)_h \approx 3 \div 5 \text{ min} \approx 2 \times 10^5$   
 (as seen from the X-ray variability)

$(\Delta W)_{eff} \approx (1 \div 3) \times 10^{23} \text{ erg}$

Number of nanoflares and filaments per pixel

$I_0 = C S \tau_c q \approx 10^3 \Rightarrow q \approx 5 \times 10^6 \text{ erg/cm}^2 \cdot \text{s}$   
 $\dot{N} = \frac{q \times S}{(\Delta W)} \approx 15^1$ ;  $N = \dot{N} (\Delta t)_h \approx 300$

Nanoflare occurrence rate for the whole active region

$S \approx 10^{20} \text{ cm}^2 \Rightarrow \dot{N} \sim 5 \times 10^3 \text{ nanoflares/sec}$